


<b>Search Notes</b>  	<b>Application/Control No.</b>  10532376	<b>Applicant(s)/Patent Under Reexamination</b>  LICH ET AL.
	<b>Examiner</b>  Dalena Tran	<b>Art Unit</b>  3664

SEARCHED			
Class	Subclass	Date	Examiner
701	124, 45-48, 36		
307	9.1		
340	425.5, 435, 436		
180	271, 282	1/1/09	DT

SEARCH NOTES			
Search Notes		Date	Examiner
EAST		1/1/09	DT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
180	271	1/1/09	DT

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